

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10520787	MIYOSHI ET AL.
	Examiner	Art Unit
	Miah, Liton	2617

SEARCHED

Class	Subclass	Date	Examiner
370	329	9/25/2007	Liton Miah
370	331	9/25/2007	Liton Miah
370	235	9/25/2007	Liton Miah
714	707	9/25/2007	Liton Miah
714	708	9/25/2007	Liton Miah
714	704	9/25/2007	Liton Miah
Search	Updated	3/18/2008	Liton Miah
Search	Updated	6/19/2008	Liton Miah
Search	Updated	12/15/2008	Liton Miah

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB)	9/25/2007	Liton Miah
Consulted with Spe (Rafael Gutierrez-Perez)	9/25/2007	Liton Miah
Inventorship Search	9/25/2007	Liton Miah
Search Updated	3/18/2008	Liton Miah
Search Updated	6/19/2008	Liton Miah
Search Updated	12/15/2008	Liton Miah
Consulted with Spe (Rafael Gutierrez-Perez)	3/11/2009	Liton Miah
Search Updated	3/16/2009	Liton Miah
Search Updated	10/22/2009	Liton Miah
search updated	4/23/2010	Liton Miah
Consulted with Spe (Rafael Gutierrez-Perez)	9/23/2010	Liton Miah
search updated	9/24/2010	Liton Miah
search updated	2/11/2011	Liton Miah

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner